

RXO7050M

The RXO7050M Crystal Oscillator (XO) is engineered to deliver exceptional jitter performance, achieving a low RMS phase jitter of 0.1 ps max. (measured from 12 kHz to 20 MHz offset). The $7.0 \times 5.0 \times 1.4$ mm Surface-Mount Device (SMD) is an ideal solution where low RMS jitter is required.

This XO offers various frequency stability options over a wide operating temperature range, accounting for initial frequency calibration, supply and load variations, and one-year ageing effects. Supporting a broad spectrum of industry-standard frequencies from 13.5 to 800 MHz, the RXO7050M is suitable for diverse applications across data centres, networking, instrumentation, and more.

Features

Frequency (Fn): 13.5 to 800 MHz

- Output: LVPECL, LVDS or HCSL
- Wide frequency range
- Operating temperature: -40 to 85°C
- Low phase noise and RMS jitter

Applications

- Data centre, Telecom, Networking, Server, Storage, Instrumentation
- GB Ethernet, SONET, SATA, SAS, Fibre Channel, PCI-Express

7.0 x 5.0 x 1.4 mm



Standard Specifications

Parameter		Min.	Тур.	Max.	Unit	Test Condition / Description
Nominal frequency (Fn)		13.5 13.5		800 160	MHz	For LVPECL, LVDS For HCSL
Temperature range		-40		85	°C	Temperature options up to 105°C are available on request
Frequency stability				±25 ~ ±100	ppm	Including frequency calibration, operating temperature range, supply and load variations, and 1 year ageing at 25°C
Supply voltage (VDD)	LVPECL LVDS, HCSL		2.5/3.3 1.8/2.5/3.3		V	With a tolerance of ±5%
Supply current	LVPECL LVDS HCSL			70 40 40	mA	
RMS phase jitter	13.5 ~ 160 MHz 160 ~ 800 MHz			0.1 ~ 1 2	ps	Integrated from 12kHz to 20MHz

Model Outline and Recommended Pad Layout

